

Search Notes

Application/Control No.

10/519,672

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

MATSUHASHI ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	255	10/13/2006	DB
	332.1		
	249		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR